



Report No.: SZ11070178H01

HAC TEST REPORT

Issued to

Senior Tech LLC

For

GSM Mobile Phone

Model Name : ez TWO-A
Trade Name : Snapfon
Brand Name : Snapfon
FCC ID : ZXLEZTWOA
Standard : ANSI C 63.19:2007
HAC Level : H-Field: M4
E-Field: M3
Test date : 2011-08-28
Issue date : 2011-09-5

Shenzhen MORLAB Communication Technology Co., Ltd.



Tested by

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2011.09.05

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Review by

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Date

2011.09.05

CTIA Authorized Test Lab
LAB CODE 20081223-00
IEEE 1725

OTA

OFTA
電訊管理局



GCF
Official Observer of
Global Certification Forum

Bluetooth
BQTF

FCC
Reg. No.
741109

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1.1. Identification of the Responsible Testing Laboratory

Company Name: Shenzhen Morlab Communications Technology Co., Ltd.
Department: Morlab Laboratory
Address: 3/F, Electronic Testing Building, Shahe Road, Nanshan District, Shenzhen, 518055 P. R. China
Responsible Test Lab Manager: Mr. Shu Luan
Telephone: +86 755 86130268
Facsimile: +86 755 86130218

1.2. Identification of the Responsible Testing Location

Name: Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory
Address: 3/F, Electronic Testing Building, Shahe Road, Nanshan District, Shenzhen, 518055 P. R. China

1.3. Accreditation Certificate

Accredited Testing Laboratory: No. CNAS L1659

1.4. List of Test Equipments

| No. | Instrument | Type |
|-----|----------------------|--|
| 1 | PC | Dell (Pentium IV 2.4GHz, SN:X10-23533) |
| 2 | Network Emulator | Rohde&Schwarz (CMU200, SN:105894) |
| 3 | Voltmeter | Keithley (2000, SN:1000572) |
| 4 | Synthesizer | Rohde&Schwarz (SML_03, SN:101868) |
| 5 | Amplifier | Nucl udes (ALB216, SN:10800) |
| 6 | Power Meter | Rohde&Schwarz (NRVD, SN:101066) |
| 7 | Audio DAQ | NI (MonDAQ, SN:MonNumero) |
| 8 | E-FIELD PROBE | SN: SN 41/08 EPH17 |
| 9 | H-FIELD PROBE | SN: SN 41/08 HPH18 |
| 10 | T-COIL PROBE | SN: SN 39/08 TCP11 |
| 11 | 800-950 MHZ DIPOLE | SN: SN 36/08 DHA16 |
| 12 | 1700-2000 MHZ DIPOLE | SN: SN 36/08 DHB16 |
| 13 | HAC holder | SN02_EPH02 (SN:SN_3608_SUPH16) |

2. Technical Information

Note: the following data is based on the information by the applicant.

2.1. Identification of Applicant

Company Name: Senior Tech LLC
Address: 1222 Tremont Street, Suite 100 Chattanooga, TN 37405, USA

2.2. Identification of Manufacturer

Company Name: Hong Kong DO COM Products Limited
Address: MSC3183, RM1007,10F., HOKING CENTER, NO.2-16 FA YUEN STREET MONGKOK, KOWLOON, HONG KONG

2.3. Equipment Under Test (EUT)

Brand Name: Snapfōn
Type Name: Snapfōn
Marking Name: ez TWO-A
Hardware Version: V2.1
Software Version: V2.1
Frequency Bands: GSM850MHz PCS 1900MHz
Tx Frequencies: 824.20 - 848.80 MHz (GSM 850)
1850.20 - 1909.80 MHz (GSM 1900)
Antenna type: Fixed Internal Antenna
Development Stage: Identical prototype
Battery Model: BTR209
Battery specification: 1450mAh 3.7V
Development Stage: Identical prototype
Classification: Licensed Transmitter Held to Ear
EUT Type: 850/1900 GSM/GPRS
HAC Test: GSM 850, 975, 38, 124, BT Off
Configurations: GSM 1900, 512, 698, 885, BT Off

2.3.1. Photographs of the EUT

Please see for photographs of the EUT.

2.3.2. Identification of all used EUTs

The EUT identity consists of numerical and letter characters, the letter character indicates the test sample, and the following two numerical characters indicate the software version of the test sample.

| EUT Identity | Hardware Version | Software Version |
|--------------|------------------|------------------|
| 1# | V2.1 | V2.1 |

2.4. Applied Reference Documents

Leading reference documents for testing:

| No. | Identity | Document Title |
|-----|--------------------------|---|
| 1 | ANSI C 63.19:2007 | American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids |

Note: Test report, reference KDB 285076 documents.

2.5. Test Environment/Conditions

| | |
|-----------------------------|--|
| Normal Temperature (NT): | 20 ... 25 °C |
| Relative Humidity: | 30 ... 75 % |
| Air Pressure: | 980 ... 1020 hPa |
| Extreme Voltage of the EUT: | Normal Voltage (NV) = 3.70V |
| | Low Voltage (LV) = 3.60V |
| | High Voltage (HV) = 4.20V |
| Test frequency: | GSM 850MHz PCS 1900MHz |
| Operation mode: | Call established |
| Power Level: | GSM 850 MHz Maximum output power(level 5) |
| | PCS 1900 MHz Maximum output power(level 0) |

During HAC test, EUT is in Traffic Mode (Channel Allocated) at Normal Voltage Condition. A communication link is set up with a System Simulator (SS) by air link, and a call is established.

The Absolute Radio Frequency Channel Number (ARFCN) is allocated to 128, 189 and 250 respectively in the case of GSM 900 MHz, or to 512, 661 and 885 respectively in the case of DCS 1800, The EUT is commanded to operate at maximum transmitting power.

2.6. Operational Conditions During Test

2.6.1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658 to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions.
- RF Magnetic- field emissions.
- T-coil mode, magnetic-signal strength in the audio band.
- T-coil mode, magnetic-signal frequency response through the audio band.
- T-coil mode, magnetic-signal and noise articulation index.

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device

2.6.2. ANSI/IEEE PC 63.19 PERFORMANCE CATEGORIES

4.3.2.1. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

850MHz Limit:

| Category | AWF (dB) | Limits for E-Field Emission (V/m) | Limits for H-Field Emission (A/m) |
|----------|----------|-----------------------------------|-----------------------------------|
| M1 | 0 | 631.0 - 1122.0 | 1.91 - 3.39 |
| | -5 | 473.2 - 841.4 | 1.43 - 2.54 |
| M2 | 0 | 354.8 - 631.0 | 1.07 - 1.91 |
| | -5 | 266.1 - 473.2 | 0.80 - 1.43 |
| M3 | 0 | 199.5 - 354.8 | 0.6 - 1.07 |
| | -5 | 149.6 - 266.1 | 0.45 - 0.80 |
| M4 | 0 | <199.5 | <0.60 |
| | -5 | <149.6 | <0.45 |

Hearing aid and WD near-field categories as defined in ANSI PC 63.19. During testing, the hearing aid must maintain an input-referenced interference level of less than 55dB a gain compression of less than 6dB.

1900MHz Limit:

| Category | AWF (dB) | Limits for E-Field Emission (V/m) | Limits for H-Field Emission (A/m) |
|----------|----------|-----------------------------------|-----------------------------------|
| M1 | 0 | 199.5 - 354.8 | 0.6 - 1.07 |
| | -5 | 149.6 - 266.1 | 0.45 - 0.8 |
| M2 | 0 | 112.2 - 199.5 | 0.34 - 0.6 |
| | -5 | 84.1 - 149.6 | 0.25 - 0.45 |
| M3 | 0 | 63.1 - 112.2 | 0.19 - 0.34 |
| | -5 | 47.3 - 84.1 | 0.15 - 0.25 |
| M4 | 0 | <63.1 | <0.19 |
| | -5 | <47.3 | <0.15 |

4.3.2.2. Articulation Weighing Factor (AWF)

| Standard | Technology | AWF |
|--|-----------------|-----|
| T1/T1P1/3GPP | UMTS(WCDMA) | 0 |
| IS-95 | CDMA | 0 |
| iden | GSM(22and 11Hz) | 0 |
| J-STD-007 | GSM(217Hz) | -5 |
| AWF has been developed from information presented to the committee regarding the interference potential of the various modulation types according to ANSI PC 63.19 | | |

2.6.3. Description of Test System

4.3.3.1. COMO HAC E-FIELD PROBE



| | |
|---|---|
| Serial Number: | SN 41/08 EPH17 |
| Frequency: | 100MHz – 3GHz |
| Probe length: | 330mm |
| Length of one dipole: | 3.3mm |
| Maximum external diameter: | 8mm |
| Probe extremity diameter: | 6mm |
| Distance between dipoles/probe extremity: | 3mm |
| Resistance of the three dipole (at the connector): | Dipole 1:R1=2.1807 MΩ Dipole 2:R1=2.0612 MΩ Dipole 3:R3=2.1892 MΩ |
| Connector (HIROSE series SR30) | 6 wire male (Hirose SR30series) |

CALIBRATION TEST EQUIPMENT

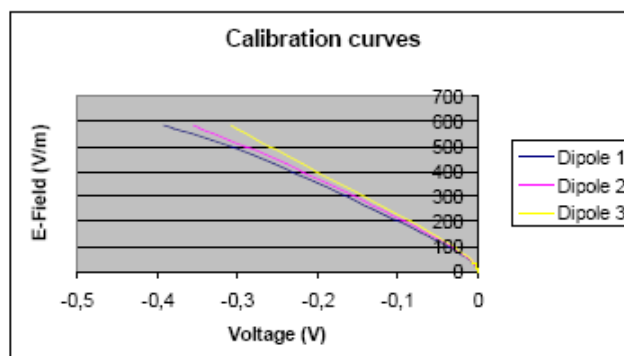
| TYPE | IDENTIFICATION |
|-------------------|---------------------------------|
| Calibration bench | SATIMO AIR CALIBRATION SOFTWARE |
| Multimeter | Keithley 2000 |

MEASUREMENT PROCEDURE

Probe calibration is realized by using the waveguide method. The probe was inserted in a waveguide loading by a 50 load. By controlling the input power in the waveguide, we are able to create a know EField value in the waveguide. ,

Keithley configuration:

Rate = Medium; Filter =ON; RDGS=10; FILTER TYPE =MOVING AVERAGE; RANGE AUTO



The following tables represent the calibration curves linearization by curve segment in CW signal.

4.3.3.2. COMO HAC H-FIELD PROBE



| | |
|---|---|
| Serial Number: | SN 41/08 HPH18 |
| Frequency: | 100MHz – 3GHz |
| Probe length: | 330mm |
| Length of one dipole: | 3.3mm |
| Maximum external diameter: | 8mm |
| Probe extremity diameter: | 6mm |
| Distance between dipoles/probe extremity: | 3mm |
| Resistance of the three dipole (at the connector): | Dipole 1:R1=2.1650 MΩ Dipole 2:R1=2.2176 MΩ Dipole 3:R3=2.4084 MΩ |
| Connector (HIROSE series SR30) | 6 wire male (Hirose SR30series) |

CALIBRATION TEST EQUIPMENT

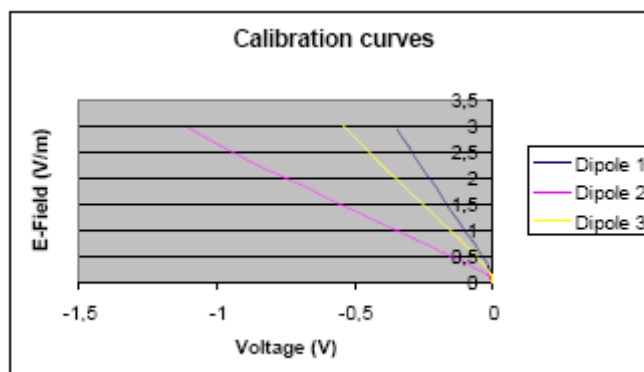
| TYPE | IDENTIFICATION |
|-------------------|------------------------|
| Calibration bench | SATIMO AIR CALIBRATION |
| | SOFTWARE |
| Multimeter | Keithley 2000 |

MEASUREMENT PROCEDURE

Probe calibration is realized by using the waveguide method. The probe was inserted in a waveguide loading by a 50 load. By controlling the input power in the waveguide, we are able to create a know HField value in the waveguide.

Keithley configuration:

Rate = Medium; Filter =ON; RDGS=10; FILTER TYPE =MOVING AVERAGE; RANGE AUTO



The following tables represent the calibration curves linearization by curve segment in CW signal.

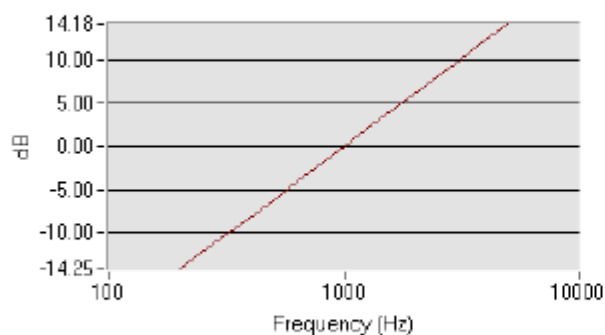
4.3.3.3. COMO HAC T-COIL PROBE



| | |
|----------------|-------------------------------|
| Serial Number: | SN 39/08 TCP11 |
| Dimensions: | 6.55mm length*2.29mm diameter |
| DC resistance: | 860.6Ω |
| Wire size: | 51 AWG |
| Inductance: | 132.1 mH at 1kHz |
| Sensitivity: | -60.22 dB (V/A/m) at 1kHz |

SENSITIVITY

Probe coil sensitivity relative to sensitivity at 1000 Hz



| Frequency (Hz) | H (dB (V/(A/m))) |
|----------------|------------------|
| 200 | -73,92940009 |
| 250 | -72,01119983 |
| 315 | -70,06378892 |
| 400 | -67,88880017 |
| 500 | -66,00059991 |
| 630 | -64,07318901 |
| 800 | -62,00820026 |
| 1000 | -60,22 |
| 1250 | -58,29179974 |
| 1600 | -56,20760035 |
| 2000 | -54,31940009 |
| 2500 | -52,36119983 |
| 3150 | -50,38378892 |
| 4000 | -48,50880017 |
| 5000 | -46,44059991 |

LINEARITY

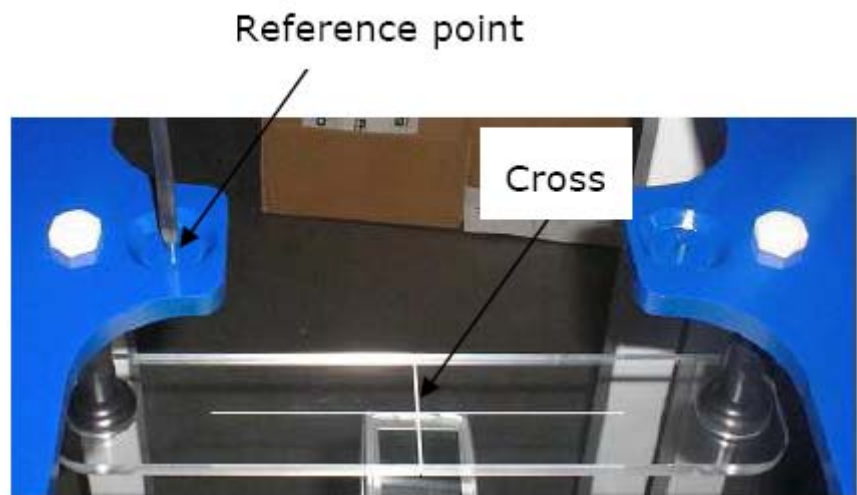
Linearity = 0.27 dB

| | | | | | | |
|---------------------------------|---|-------|--------|-----|-------|--------|
| Power (dB) relative to 1 A/m | 0 | -10 | -20 | -30 | -40 | -50 |
| H (dB (V/(A/m))) | 0 | -9,95 | -19,95 | -30 | -39,9 | -49,73 |

4.3.3.4. System Hardware

The HAC positioning ruler is used to position the phone properly with the regard to the position of the probe during a measurement. The positioning system is made of a dedicated frame that can be fixed on the table. The tip of the probe is positioned on a reference point located on the top of the positioning ruler. The distance between this reference point and the cross located on the ruler being known, the speaker of the phone is positioned on this cross in order to make sure both probe and phone are positioned properly.

During the measurement, the HAC ruler has to be removed so that it does not interfere with the measurement.



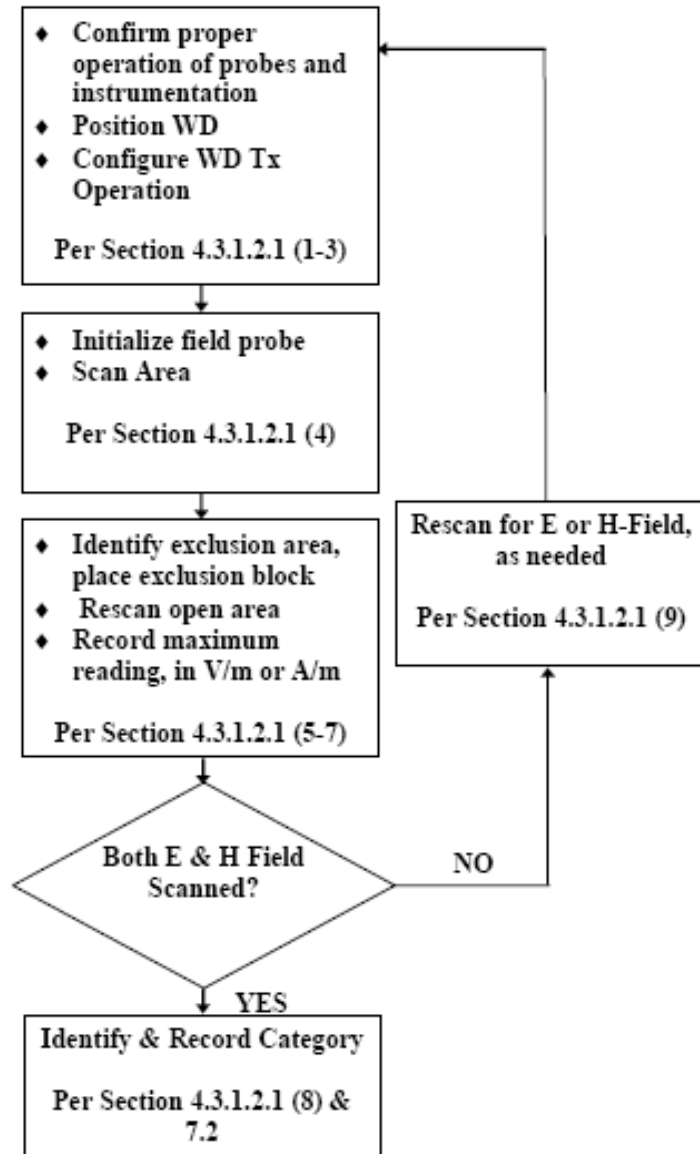
HAC positioning ruler

2.6.4. TEST PROCEDURE

4.3.4.1. RF EMISSIONS

Per ANSI C 63.19 2007:

Test Instructions



4.3.4.2.TEST Setup



WD reference and plane for RF emission measurements

4.3.4.3.RF Emission Test Procedure

The following illustrate a typical RF emissions test scan over a wireless communications device:

1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
6. The measurement system measured the field strength at the reference location.

2.6.5. SYSTEM CHECK

4.3.5.1. System Check Parameters

The input signal was an unmodulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power $P = 100\text{mW RMS}$ (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:

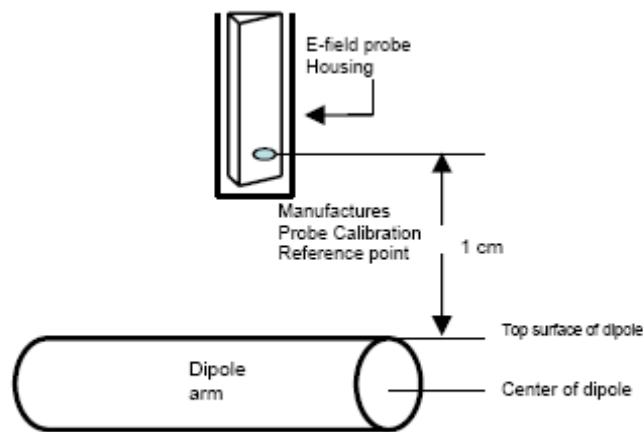


Figure 15
Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

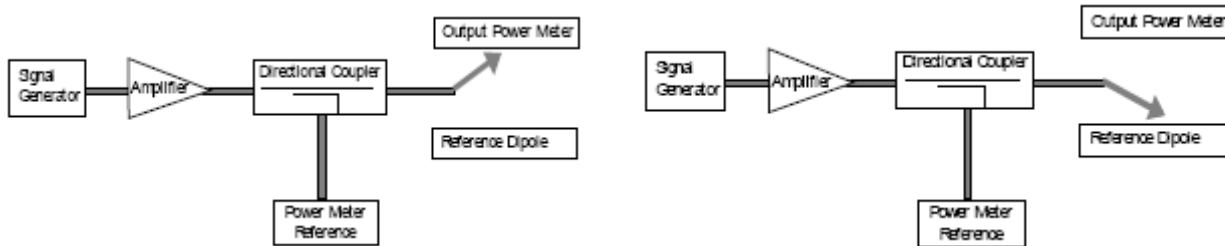
4.3.5.2 Validation Procedure

A dipole antenna meeting the requirements given in PC63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded.

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup see manufacturer method on dipole calibration certificates, Field strength measurements shall be made only when the probe is stationary.

RF power was recorded using both an average and a peak power reading meter.



Setup for Desired Output Power to Dipole

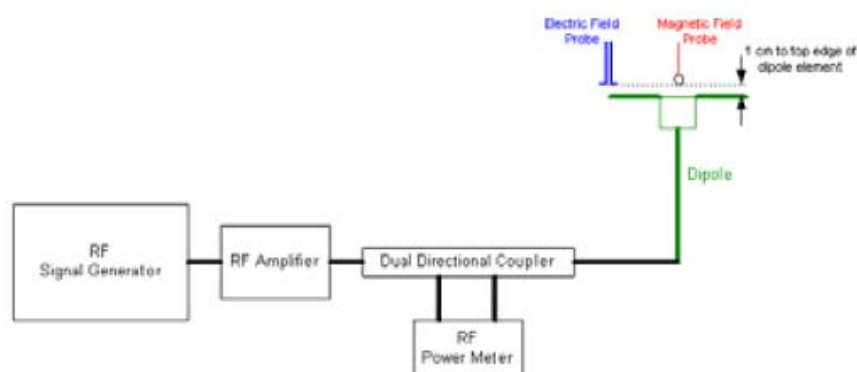
Setup to Dipole

Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole,

4.3.5.3. Test System Validation

Validation Results (1W forward input power), System checks the specific test data please see page 49-56

| Frequency | Input Power (dBm) | E-field Result (V/m) | Target Field (V/m) |
|-----------|-------------------|----------------------|--------------------|
| 900 MHz | 20.0 | 207 | 205 |
| 1800MHz | 20.0 | 161.52 | 165 |
| Frequency | Input Power (dBm) | H-field Result (A/m) | Target Field (A/m) |
| 900 MHz | 20.0 | 0.442 | 0.448 |
| 1800MHz | 20.0 | 0.447 | 0.452 |



System Check Setup

2.6.6. Uncertainty Estimation Table

| a | b | c | d | e= f(d,k) | f | g | h= c*f/e | i= c*g/e | k |
|---|---------|--------------|----------------|------------|---------|-------------|----------------|-----------------|-------------|
| Uncertainty Component | Sec. | Tol (+-%) | Prob. Dist. | Div. | Ci (1g) | Ci (10g) | 1g Ui (+-%) | 10g Ui (+-%) | V i |
| Measurement System | | | | | | | | | |
| Probe calibration | E.2.1 | 7.0 | N | 1 | 1 | 1 | 7.00 | 7.00 | |
| Axial Isotropy | E.2.2 | 2.5 | R | $\sqrt{3}$ | | | 1.02 | 1.02 | |
| Hemispherical Isotropy | E.2.2 | 4.0 | R | $\sqrt{3}$ | | | 1.63 | 1.63 | |
| Boundary effect | E.2.3 | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.58 | 0.58 | |
| Linearity | E.2.4 | 5.0 | R | $\sqrt{3}$ | 1 | 1 | 2.89 | 2.89 | |
| System detection limits | E.2.5 | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.58 | 0.58 | |
| Readout Electronics | E.2.6 | 0.02 | N | 1 | 1 | 1 | 0.02 | 0.02 | |
| Reponse Time | E.2.7 | 3.0 | R | $\sqrt{3}$ | 1 | 1 | 1.73 | 1.73 | |
| Integration Time | E.2.8 | 2.0 | R | $\sqrt{3}$ | 1 | 1 | 1.15 | 1.15 | |
| RF ambient Conditions | E.6.1 | 3.0 | R | $\sqrt{3}$ | 1 | 1 | 1.73 | 1.73 | |
| Probe positioner Mechanical Tolerance | E.6.2 | 2.0 | R | $\sqrt{3}$ | 1 | 1 | 1.15 | 1.15 | |
| Probe positioning with respect to Phantom Shell | E.6.3 | 0.05 | R | $\sqrt{3}$ | 1 | 1 | 0.03 | 0.03 | |
| Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation | E.5.2 | 5.0 | R | $\sqrt{3}$ | 1 | 1 | 2.89 | 2.89 | |
| Test sample Related | | | | | | | | | |
| Test sample positioning | E.4.2.1 | 0.03 | N | 1 | 1 | 1 | 0.03 | 0.03 | N - 1 |
| Device Holder Uncertainty | E.4.1.1 | 5.00 | N | 1 | 1 | 1 | 5.00 | 5.00 | |
| Output power Variation - drift measurement | 6.6.2 | 5.78 | R | | 1 | 1 | 3.34 | 3.34 | |

2.6.7. OVERALL MEASUREMENT SUMMARY

4.3.7.1 E-FIELD EMISSIONS

| Band | Mode | Channel | M Rating | Output power (dBm) |
|-------------------|------|---------|----------|-----------------------|
| E-FIELD EMISSIONS | | | | |
| GSM850 | GSM | 128 | M4 | 32.41 |
| GSM850 | GSM | 189 | M4 | 32.36 |
| GSM850 | GSM | 250 | M4 | 32.21 |
| GSM1900 | GSM | 513 | M3 | 27.82 |
| GSM1900 | GSM | 661 | M3 | 27.84 |
| GSM1900 | GSM | 809 | M3 | 28.14 |

4.3.7.2 H-FIELD EMISSIONS

| Band | Mode | Channel | M Rating | Output power (dBm) |
|-------------------|------|---------|----------|-----------------------|
| H-FIELD EMISSIONS | | | | |
| GSM850 | GSM | 128 | M4 | 32.41 |
| GSM850 | GSM | 189 | M4 | 32.36 |
| GSM850 | GSM | 250 | M4 | 32.21 |
| GSM1900 | GSM | 513 | M4 | 27.82 |
| GSM1900 | GSM | 661 | M4 | 27.84 |
| GSM1900 | GSM | 809 | M4 | 28.14 |

2.6.8. TEST DATA

| <u>FREQUENCY</u> | <u>PARAMETERS</u> |
|------------------------|---|
| <u>GSM 850</u> | <u>Measurement 1:</u> Efield on Low Channel <u>Measurement 2:</u> Hfield on Low Channel <u>Measurement 3:</u> Efield on Middle Channel <u>Measurement 4:</u> Hfield on Middle Channel <u>Measurement 5:</u> Efield on High Channel <u>Measurement 6:</u> Hfield on High Channel |
| <u>GSM 1900</u> | <u>Measurement 7:</u> Efield on Low Channel <u>Measurement 8:</u> Hfield on Low Channel <u>Measurement 9:</u> Efield on Middle Channel <u>Measurement 10:</u> Hfield on Middle Channel <u>Measurement 11:</u> Efield on High Channel <u>Measurement 12:</u> Hfield on High Channel |

MEASUREMENT 1

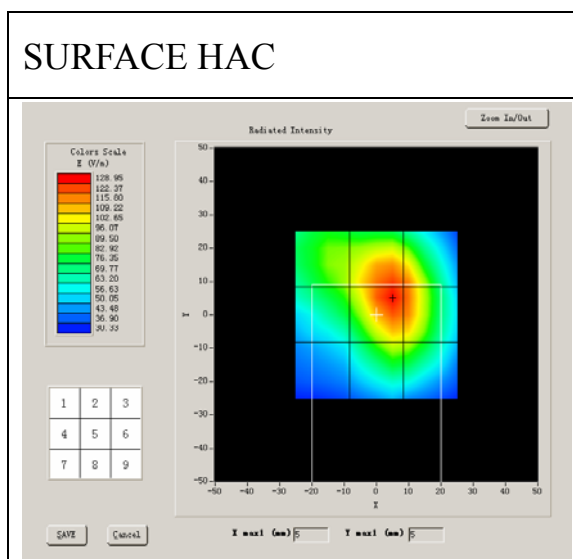
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | Low |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Lower Band (Channel 128):

Frequency (MHz): 824.200000



Probe Modulation Factor = 2.820000

Maximum value of total field = 128.95 V/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|---------------|-------------------|-------------------|
| Grid 1: 95.56 | Grid 2: 123.28 | Grid 3: 115.84 |
| Grid 4: 94.44 | Grid 5: 128.95 | Grid 6: 117.89 |
| Grid 7: 61.72 | Grid 8: 100.06 | Grid 9: 95.92 |

MEASUREMENT 2

A. Experimental conditions.

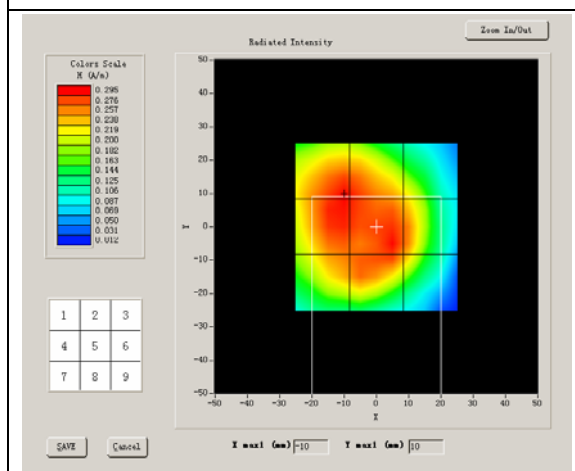
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | Low |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Lower Band (Channel 128):

Frequency (MHz): 824.200000

SURFACE HAC



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.29 A/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.29 | Grid 2: 0.29 | Grid 3: 0.22 |
| Grid 4: 0.29 | Grid 5: 0.29 | Grid 6: 0.26 |
| Grid 7: 0.26 | Grid 8: 0.29 | Grid 9: 0.24 |

MEASUREMENT 3

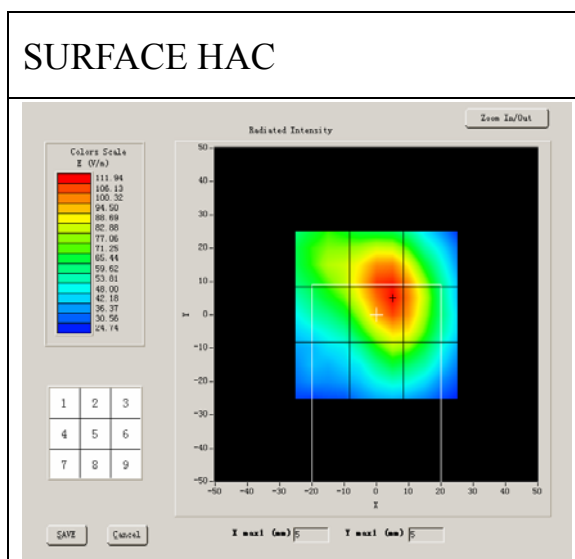
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | Middle |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Middle Band (Channel 189):

Frequency (MHz): 836.400000



Probe Modulation Factor = 2.820000

Maximum value of total field = 111.94 V/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|---------------|-------------------|-------------------|
| Grid 1: 85.80 | Grid 2: 110.26 | Grid 3: 98.59 |
| Grid 4: 84.37 | Grid 5: 111.94 | Grid 6: 101.20 |
| Grid 7: 53.22 | Grid 8: 85.00 | Grid 9: 81.75 |

MEASUREMENT 4

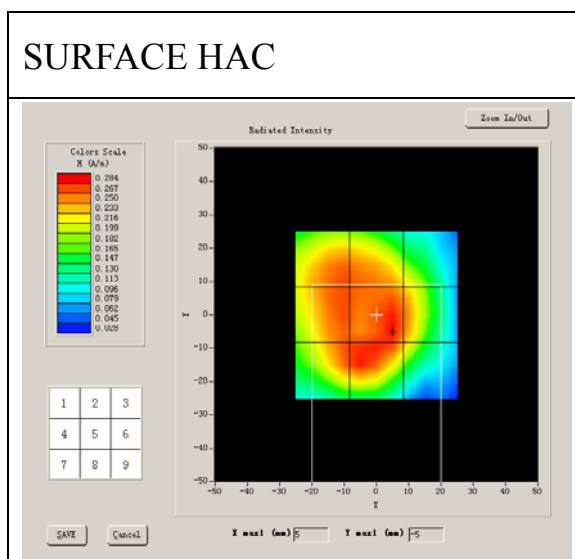
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | Middle |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Middle Band (Channel 189):

Frequency (MHz): 836.400000



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.28 A/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.27 | Grid 2: 0.26 | Grid 3: 0.21 |
| Grid 4: 0.27 | Grid 5: 0.28 | Grid 6: 0.25 |
| Grid 7: 0.28 | Grid 8: 0.28 | Grid 9: 0.22 |

MEASUREMENT 5

A. Experimental conditions.

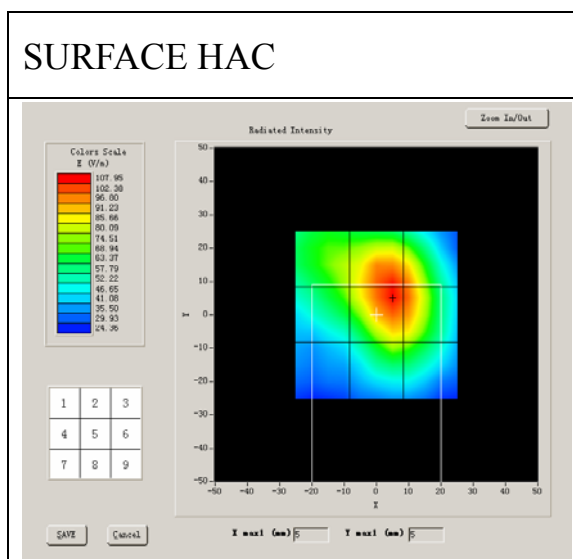
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | High |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Higher Band (Channel 250):

Frequency (MHz): 848.600000

SURFACE HAC



Probe Modulation Factor = 2.820000

Maximum value of total field = 108.28 V/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|---------------|-------------------|---------------|
| Grid 1: 80.29 | Grid 2: 106.04 | Grid 3: 96.56 |
| Grid 4: 79.17 | Grid 5: 108.28 | Grid 6: 99.51 |
| Grid 7: 48.36 | Grid 8: 81.39 | Grid 9: 77.14 |

MEASUREMENT 6

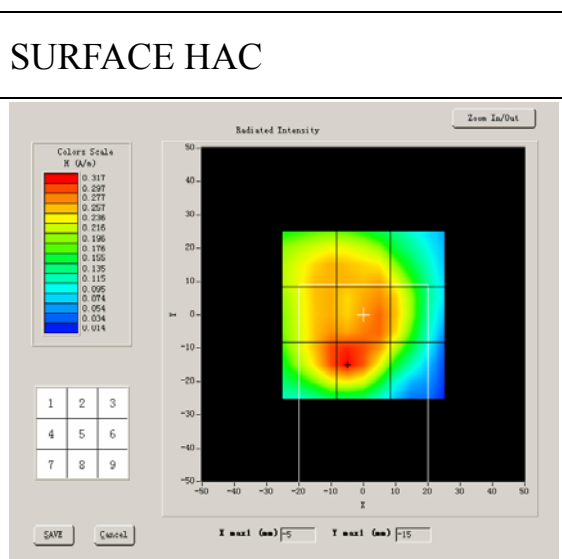
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM850 |
| Channel | High |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Higher Band (Channel 250):

Frequency (MHz): 848.600000



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.29 A/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.26 | Grid 2: 0.27 | Grid 3: 0.23 |
| Grid 4: 0.28 | Grid 5: 0.29 | Grid 6: 0.26 |
| Grid 7: 0.32 | Grid 8: 0.32 | Grid 9: 0.23 |

MEASUREMENT 7

A. Experimental conditions.

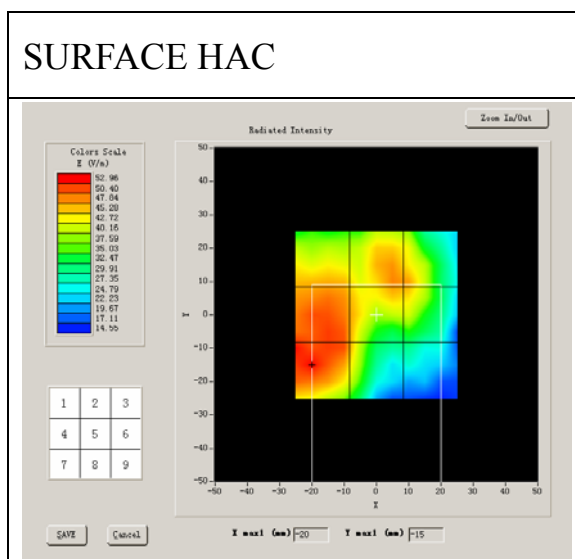
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | Low |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Lower Band (Channel 512):

Frequency (MHz): 1850.400000

SURFACE HAC



Probe Modulation Factor = 2.820000

Maximum value of total field = 48.05 V/m

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| | | |
|---------------|---------------|---------------|
| Grid 1: 46.16 | Grid 2: 48.05 | Grid 3: 46.71 |
| Grid 4: 51.45 | Grid 5: 47.68 | Grid 6: 46.48 |
| Grid 7: 52.96 | Grid 8: 44.30 | Grid 9: 30.83 |

MEASUREMENT 8

A. Experimental conditions.

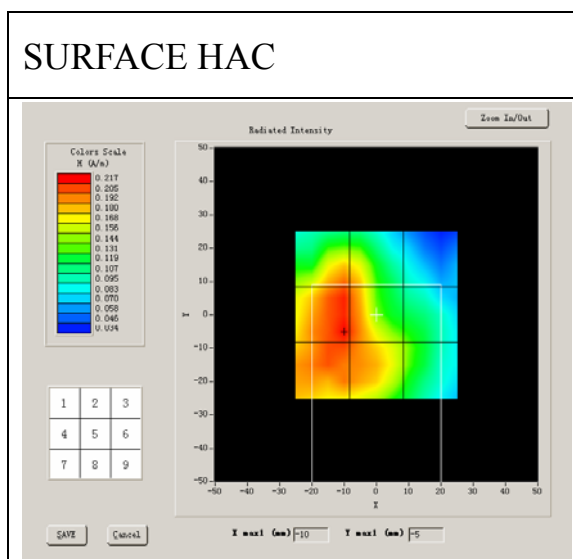
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | Low |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Lower Band (Channel 512):

Frequency (MHz): 1850.400000

SURFACE HAC



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.20 A/m

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.20 | Grid 2: 0.19 | Grid 3: 0.09 |
| Grid 4: 0.22 | Grid 5: 0.20 | Grid 6: 0.13 |
| Grid 7: 0.21 | Grid 8: 0.20 | Grid 9: 0.14 |

MEASUREMENT 9

A. Experimental conditions.

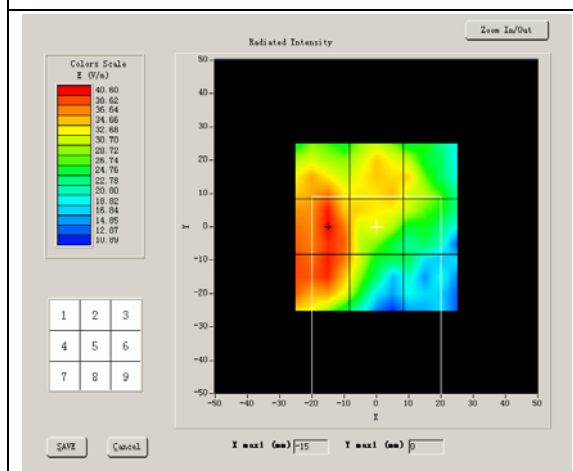
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | Middle |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Middle Band (Channel 661):

Frequency (MHz): 1880.000000

SURFACE HAC



Probe Modulation Factor = 2.820000

Maximum value of total field = 34.56 V/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|---------------|---------------|---------------|
| Grid 1: 37.21 | Grid 2: 34.56 | Grid 3: 33.79 |
| Grid 4: 40.60 | Grid 5: 34.30 | Grid 6: 31.18 |
| Grid 7: 39.94 | Grid 8: 33.32 | Grid 9: 24.27 |

MEASUREMENT 10

A. Experimental conditions.

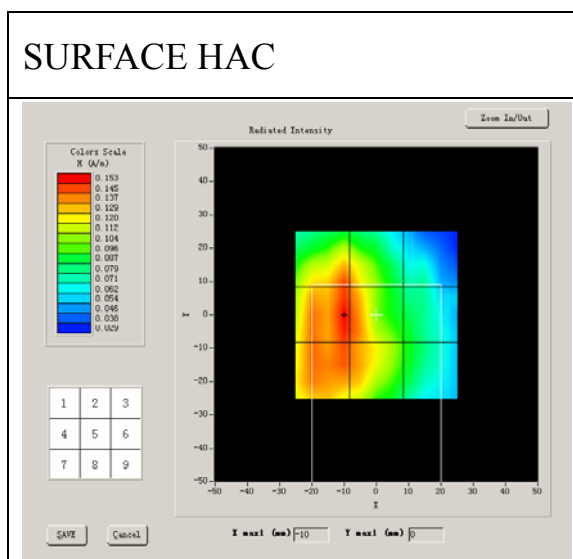
| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | Middle |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Middle Band (Channel 661):

Frequency (MHz): 1880.000000

SURFACE HAC



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.15 A/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.15 | Grid 2: 0.13 | Grid 3: 0.07 |
| Grid 4: 0.15 | Grid 5: 0.15 | Grid 6: 0.09 |
| Grid 7: 0.15 | Grid 8: 0.14 | Grid 9: 0.09 |

MEASUREMENT 11

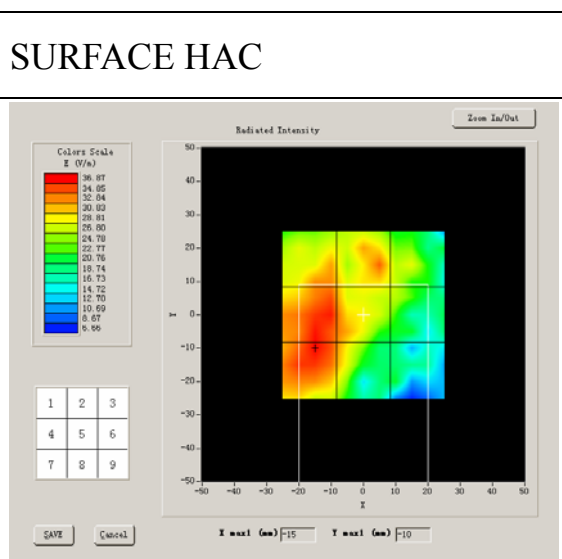
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | High |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Higher Band (Channel 809):

Frequency (MHz): 1909.600000



Probe Modulation Factor = 2.820000

Maximum value of total field = 34.13 V/m

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|---------------|---------------|---------------|
| Grid 1: 33.39 | Grid 2: 34.13 | Grid 3: 27.97 |
| Grid 4: 36.65 | Grid 5: 32.80 | Grid 6: 26.54 |
| Grid 7: 36.87 | Grid 8: 31.60 | Grid 9: 21.72 |

MEASUREMENT 12

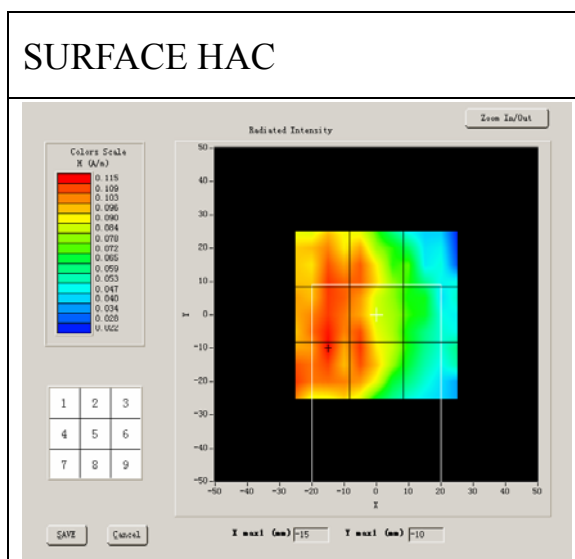
A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | GSM1900 |
| Channel | High |
| Signal | TDMA |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Higher Band (Channel 809):

Frequency (MHz): 1909.600000






Probe Modulation Factor = 2.800000

Maximum value of total field = 0.11 A/m

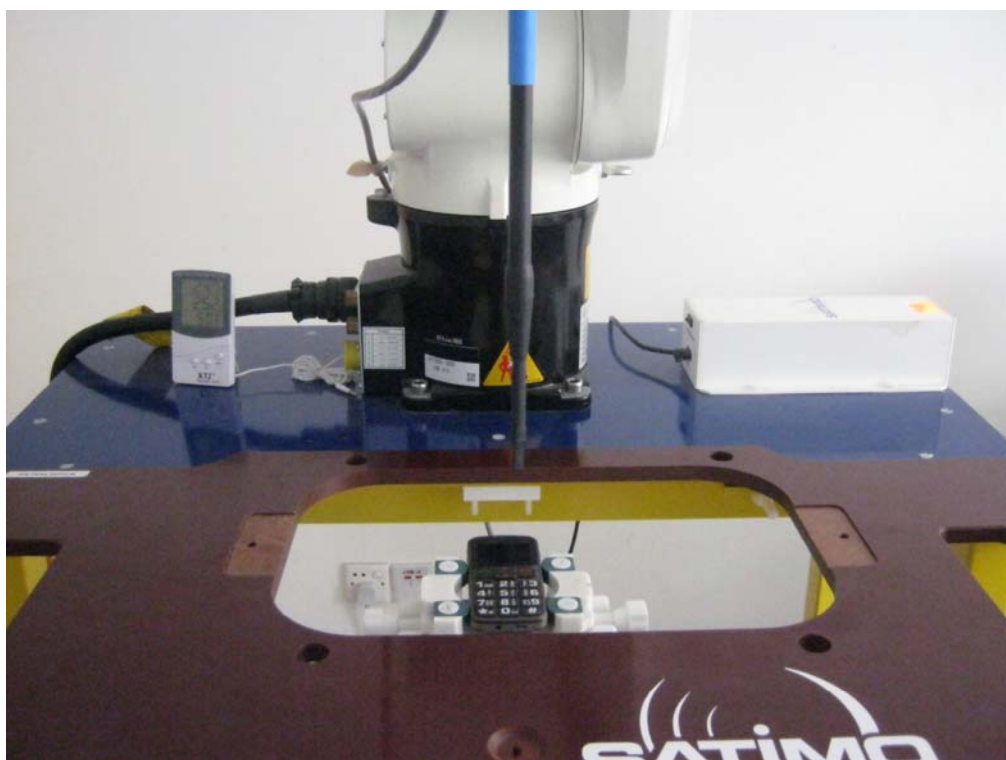
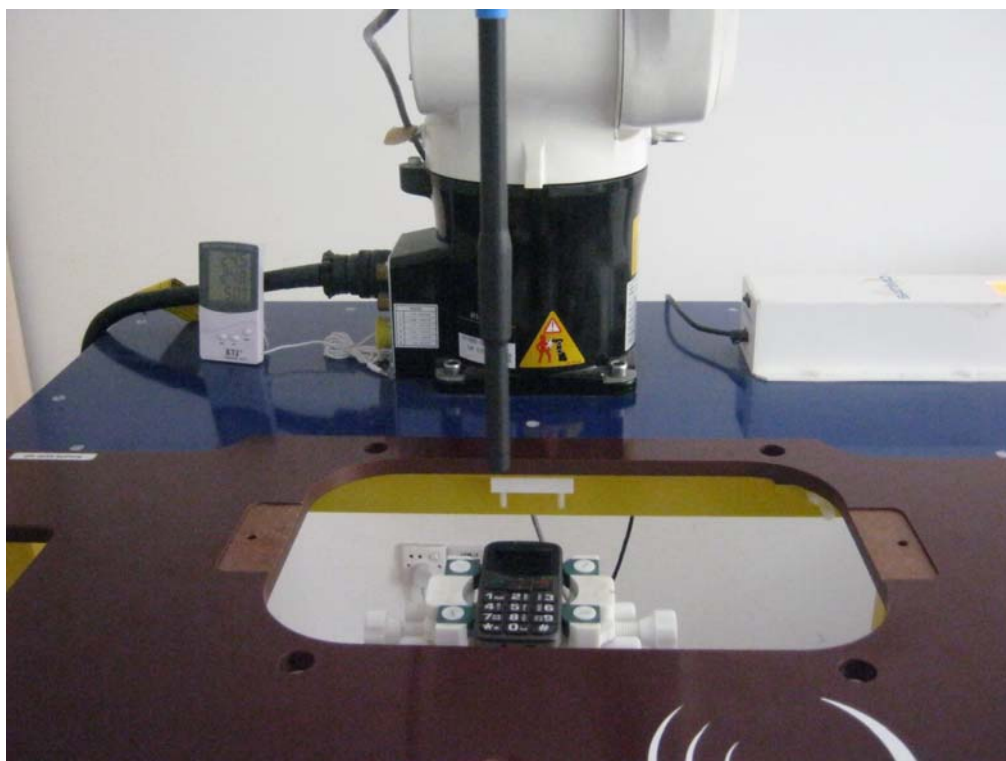
Hearing Aid Near-Field Category: M4 (AWF -5 dB)

| | | |
|--------------|--------------|--------------|
| Grid 1: 0.11 | Grid 2: 0.11 | Grid 3: 0.07 |
| Grid 4: 0.11 | Grid 5: 0.11 | Grid 6: 0.07 |
| Grid 7: 0.12 | Grid 8: 0.11 | Grid 9: 0.07 |

Annex A Accreditation Certificate

| |
|---|
|   |
| China National Accreditation Service for Conformity Assessment |
| LABORATORY ACCREDITATION CERTIFICATE |
| (No. CNAS L1659) |
| <i>China National Accreditation Service for Conformity Assessment has accredited</i> |
| Shenzhen Electronic Product Quality Testing Center |
| <u>Electronic Testing Building, Shahe Road, Xili, Nanshan District,</u> |
| <u>Shenzhen, Guangdong, China</u> |
| <i>to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories(CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing and calibration.</i> |
| <i>The scope of accreditation is detailed in the attached schedule bearing the same accreditation number as above. The schedule forms an integral part of this certificate.</i> |
| Date of Issue: 2009-09-29 |
| Date of Expiry: 2012-09-28 |
| Date of Initial Accreditation: 1999-08-03 |
|  |
| Signed on behalf of China National Accreditation Service for Conformity Assessment |
| <small>China National Accreditation Service for Conformity Assessment(CNAS) is authorized by Certification and Accreditation Administration of the People's Republic of China (CNCA) to operate the national accreditation systems for conformity assessment. CNAS is the signatory to International Laboratory Accreditation Cooperation Multilateral Recognition Arrangement (ILAC MRA), and the signatory to Asia Pacific Laboratory Accreditation Cooperation Multilateral Recognition Arrangement (APLAC MRA).</small> |

Annex B Photographs of the EUT



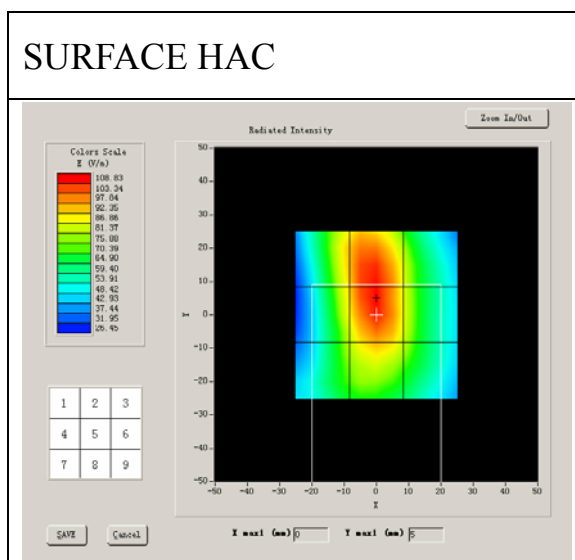
System Performance Check (E-field)

A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | 850 MHz |
| Channel | |
| Signal | CW |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Frequency (MHz): 850.000000



Probe Modulation Factor = 2.820000

Maximum value of total field = 205 V/m

E in V/m

| | | |
|-------------------|-------------------|-------------------|
| Grid 1: 194.51 | Grid 2: 198.12 | Grid 3: 177.56 |
| Grid 4: 192.69 | Grid 5: 205.00 | Grid 6: 178.98 |
| Grid 7: 181.13 | Grid 8: 194.18 | Grid 9: 176.51 |

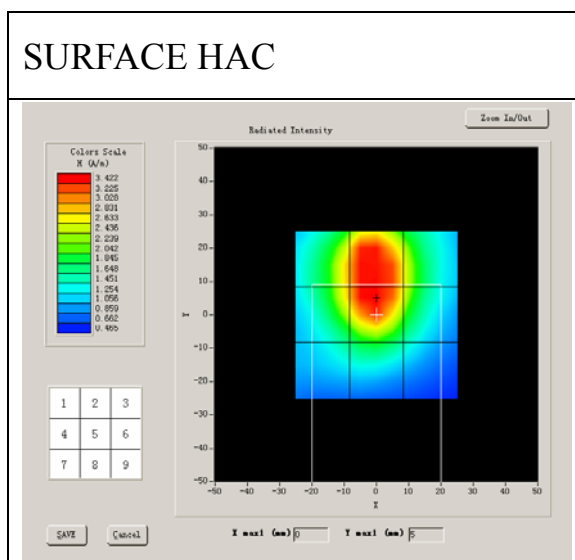
System Performance Check (H-field)

A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | 850 MHz |
| Channel | |
| Signal | CW |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Frequency (MHz): 850.000000



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.448 A/m

H in A/m

| | | |
|---------------|---------------|---------------|
| Grid 1: 0.302 | Grid 2: 0.421 | Grid 3: 0.336 |
| Grid 4: 0.381 | Grid 5: 0.449 | Grid 6: 0.332 |
| Grid 7: 0.370 | Grid 8: 0.400 | Grid 9: 0.239 |

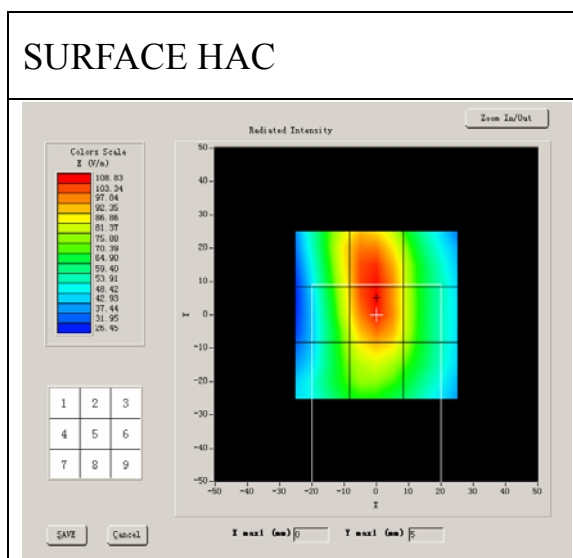
System Performance Check (E-field)

A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | 1800 MHz |
| Channel | |
| Signal | CW |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Frequency (MHz): 1800.000000



Probe Modulation Factor = 2.820000

Maximum value of total field = 161.52V/m

E in V/m

| | | |
|-------------------|-------------------|-------------------|
| Grid 1: 145.51 | Grid 2: 158.33 | Grid 3: 136.11 |
| Grid 4: 151.64 | Grid 5: 161.52 | Grid 6: 142.95 |
| Grid 7: 141.52 | Grid 8: 148.62 | Grid 9: 126.77 |

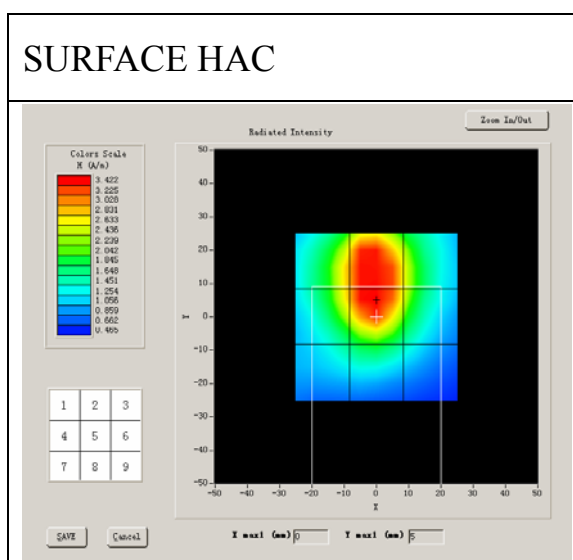
System Performance Check (H-field)

A. Experimental conditions.

| | |
|---------------------|------------|
| Grid size (mm x mm) | 50.0, 50.0 |
| Step (mm) | 5 |
| Band | 1800 MHz |
| Channel | |
| Signal | CW |
| Date of measurement | 27/8/2011 |

B. HAC Measurement Results

Frequency (MHz): 1800.000000



Probe Modulation Factor = 2.800000

Maximum value of total field = 0.447 A/m

H in A/m

| | | |
|---------------|---------------|---------------|
| Grid 1: 0.424 | Grid 2: 0.434 | Grid 3: 0.384 |
| Grid 4: 0.437 | Grid 5: 0.447 | Grid 6: 0.415 |
| Grid 7: 0.432 | Grid 8: 0.415 | Grid 9: 0.361 |